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# $\frac{1}{3}$  Analytical estimates of the pull-in voltage for carbon

- <sup>4</sup> nanotubes considering tip-charge concentration
- <sup>5</sup> and intermolecular forces

6 Giovanni Bianchi · Enrico Radio

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**nolecular forces**<br>
hi · Enrico Radio<br>
Bi-V. 2020<br>
Side accurate analytical estimates of<br>
Reywords Carbon nanotube · Pull-in<br>
meters of a carbon manotube switch<br>
meters of a carbon manotube switch<br>
and under electrostatic Abstract Two-side accurate analytical estimates of the pull-in parameters of a carbon nanotube switch clamped at one end under electrostatic actuation are provided by considering the proper expressions of the electrostatic force and van der Waals interactions for a carbon nanotube, as well as the contribution of the 15 AQ1 charge concentration at the free end. According to the Euler–Bernoulli beam theory, the problem is governed by a fourth-order nonlinear boundary value problem. Two-side estimates on the centreline deflection are derived. Then, very accurate lower and upper bounds to the pull-in voltage and deflection are obtained as 2 AQ2 function of the geometrical and material parameters. The analytical predictions are found to agree remark- ably well with the numerical results provided by the shooting method, thus validating the proposed approach. Finally, a simple closed-form relation is proposed for the minimum feasible gap and maximum realizable length for a freestanding CNT cantilever.

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Keywords Carbon nanotube · Pull-in voltage · 28 NEMS · Nanocantilever · van der Waals interactions · 29 Charge concentration 30

#### 1 Introduction 31

Carbon nanotubes (CNTs) display a number of smart 32 electronic and mechanical properties that are currently 33 exploited in a wide variety of industrial applications, 34 such as sensors, nanoactuators, memory devices, 35 switches, high frequency nanoresonators and nan- 36 otweezers [ 1 – 3]. Due to their tiny size, CNTs display 37 ultra-low mass and very high resonance frequency. 38 Moreover, they undergo purely elastic behaviour, they 39 are able to carry huge electrical currents and to sustain 40 high current densities. These attractive properties, in 41 conjunction with the significant progress recently 42 made in the fabrication of carbon nanostructures, 43 allow CNTs to become essential components in the 44 production of enhanced nano-electro-mechanical sys- 45 tems (NEMS) [ 1]. As a consequence, a considerable 46 amount of research interest has been dedicated to the 47 accurate modelling of the structural and electric 48 behavior of CNTs in the last few years. 49

A typical CNT switch consists in a moveable 50 nanowire suspended over a fixed conductive ground 51 plane, usually made of graphite. By applying DC 52 voltage difference between the components, the CNT 53





makes every attempt to describe their<br>
geometries and materials required for<br>
or other are diffucult tax, Specifical equired to solution can be found for the non-<br>
or durability. Despite the emound of n<br>
solution can be fo deflects toward the ground electrode until at the pull-in voltage it sticks on the ground plane, thus shortening the electric circuit. The atomic interactions at the nano-scale separations, modelled by the van der Waals force, substantially affects the pull-in instability of NEMS. Both the electrostatic and van der Waals forces depend on the CNT deflection non-linearly. This occurrence makes every attempt to describe their response in closed form a very difficult task. Specif- ically, no exact solution can be found for the non- linear ordinary differential equation (ODE) governing the CNT deflection under electrostatic actuation. As a consequence, a variety of numerical and approximated approaches has been proposed in the technical liter- ature, ranging from the reduction to 1D lumped models, based on the assumption of appropriate shape functions for the CNT deflection, to the use of powerful numerical techniques to generate reduced- order models, such as the Differential Quadrature Method, the Galerkin Discretization Method or the Finite Element Method [ 4 –11]. However, these approximated methods may provide significant error percentages as the CNT deflection increases and gets closer to the pull-in limit. Moreover, they predict arbitrary estimates of the effective pull-in parameters, whereas an effective approach should provide accu- rate lower and upper bounds that can be exploited for ensuring the safe operation of the device. Alterna- tively, molecular dynamics approaches have been 83 adopted to study CNTs pull-in behavior [12]. How- ever, these methods are very time-consuming and can not be easily employed for large structures.

 As remarked by Ke et al. [13 , 14], electric charges tend to concentrate at the ends of a linear conductor and thus for proper modeling of the pull-in instability phenomenon the effect of the concentrated load due to charge concentration at the end of a CNT cantilever is expected to provide a significant contribution on the deflection of CNT and consequently on the pull-in instability. Therefore, it must be necessarily consid- ered for the accurate evaluation of the pull-in voltage. In particular, Ke et al. [13] showed that the pull-in voltage decreases by about 14% due to the effect of the tip-charge concentration. They also provided an approximate relation for the pull-in voltage that account for the effects of tip-charge concentration and finite kinematics. They found that the finite kinematic effect is negligible for a CNT-based cantilever switch, but the effect of charge

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concentration is quite significant. Ke [15] also pre- 103 sented a detailed review of the recent advances in the 104 electro-mechanical modeling and characterization of 105 CNT cantilevers and their applications. 106

The development of analytical models that can 107 predict the pull-in response of the device becomes 108 extremely relevant for identifying the most efficient 109 geometries and materials required for meeting the 110 requests of ultralow power consumption, strength and 111 durability. Despite the amount of numerical and 112 approximated investigations, analytical models and 113 closed form expressions for assessing the occurring of 114 CNT pull-in instability still appears to be limited. An 115 accurate determination of the stable actuating range 116 and the pull-in instability threshold is a crucial issues 117 for the design of reliable and optimized CNT-based 118 NEMS. In two previous works, Radi et al. [16 , 17 ] 119 provided an analytical methodology for assessing 120 accurate lower and upper bounds to the pull-in 121 parameters of an electro-statically actuated micro- or 122 nano-cantilever, by taking the contributions of flexible 123 support and compressive axial load into consideration. 124 Both contributions are found to reduce the pull-in 125 voltage and to increase the critical gap spacing for a 126 freestanding nano-cantilever, namely in the absence of 127 electrical actuation. The investigations [16 , 17] have 128 focused on the pull-in instability in micro- and 129 nanobeams with rectangular cross-section only. More- 130 over, the contribution of the charge concentrated at the 131 nanocantilever tip has been neglected in these works. 132

In the present work, attention is paid to investigate 133 the pull-in phenomenon in CNT with circular cross- 134 section rolled up by graphene sheets, by considering 135 the proper expressions of the electrostatic force as well 136 as the significant effect induced by the tip-charge 137 concentration [13 , 14 , 18 , 19]. The van der Waals 138 force acting on the CNT has been derived in [ 4 ] 139 starting from the Lennard–Jones potential (see also 140 [8, 20–22]). The finite kinematic effect has been 141 neglected here, Ke et al. [13 , 14] found indeed that for 142 a clamped CNT it becomes significant only for very 143 slender CNTs and large gap spacing. Indeed, the pull- 144 in instability generally occurs as the CNT tip deflec- 145 tions attains about  $1/3 \div 1/2$  of the gap spacing, 146 which is much smaller than the CNT length. Within 147 this range, the CNT can be reasonably supposed to 148 experience small deformations and small displace- 149 ment. Therefore, reference is made here to the classic 150 Euler–Bernoulli (EB) beam theory, which is valid for 151



 most of the CNT applications as switches and actuators [23]. The main advantage of the present approach with respect to other ones proposed in literature consists in providing accurate analytical bounds from above and below for the pull-in voltage and pull-in deflection, thus avoiding the numerical integration of the nonlinear fourth-order ODE derived from the EB beam theory. Moreover, the present work extends previous investigations on nanobeams with rectangular cross section [16 , 17], which are not specifically addressed to CNTs and do not take the contribution of the concentrated-tip charge into 164 account.

intensity. Moreover, the present work<br>interactions, such as capillary and el<br>investigations on nanobeans with forces [25, 26].<br>section [16, 17], which are not<br>the concentrated-tip charge into <br>the concentrated-tip charge By introducing few non-dimensional parameters, the nonlinear ODE for the CNT centreline deflection and the corresponding boundary conditions are pre- sented in Sect. 2. Moreover, an equivalent integral equation formulation is derived therein. The nonlinear response is due to the electrostatic force and van der Waals interactions, which depends on the beam deflection nonlinearly, whereas the CNT is modelled by using a linear elastic EB beam. The solution of the boundary value problem is then proved to be positive, increasing and convex. Upper and lower estimates for the CNT deflection are obtained in Sect. 3. Accurate two-side analytical bounds to the pull-in parameters are derived in Sect. 4 by exploiting the estimates obtained in Sect. 3. The accuracy of the proposed bounds are then validated in Sect. 5 by comparing the analytical estimates and the numerical results pro- vided by the shooting method. A remarkable agree- ment is observed therein. On the basis of the obtained results, an approximated closed-form expression is finally proposed for permissible gap spacing and CNT

length under the influence of intermolecular 186 attractions. 187

The approach here proposed refers to a single- 188 walled CNT. However, it can be easily generalized to 189 multi-walled CNTs, e.g. by considering the expres- 190 sions of the electrostatic and van der Waals forces 191 provided in [24], as well as to other kinds of 192 interactions, such as capillary and electrochemical 193 forces [25, 26]. , 26]. 194

#### 2 Mathematical modeling 195

A schematic view of a CNT-based cantilever switch is 196 shown in Fig. 1. A movable single-walled or multi- 197 walled CNT is placed above a fixed ground plane and 198 subject to van der Waals interactions and attractive 199 electrostatic force due to applied voltage. The nan- 200 otube length and the cross section mean radius are 201 denoted with  $L$  and  $R$ , respectively. The gap spacing  $202$ between the nanotube and the ground plane is denoted 203 by H. The deflection  $v(z)$  of the CNT centreline is 204 described by the following non-linear fourth-order 205 ODE written in terms of the nondimensional variables 206  $u = v/H$  and  $x = z/L$  for  $0 \le x \le 1$  and  $0 \le u \le 1$  207

$$
u^{\text{IV}}(x) = f(u(x)), \text{ for } x \in [0, 1],
$$
 (1)

where the prime denotes differentiation with respect to 209 the function argument. The CNT actuation is modelled 210 by considering both contributions of electrostatic 211 force and van der Waals interactions, namely 212



Fig. 1 A CNT based cantilever switch under electrostatic loading



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$$
f(u) = \beta f_e(u) + \gamma F_c(u), \qquad (2)
$$

214 where the normalized electrostatic and van der Waals 215 forces for the cylindrical geometry are given by 216 [4, 8, 13, 14, 18-22, 27, 28]

$$
f_e(u) = \frac{1}{\sqrt{(1-u)(1-u+2/k)}[\cosh^{-1}(1+k-ku)]^2},
$$
  
\n
$$
f_c(u) = \frac{8k^4(1-u)^4 + 32k^3(1-u)^3 + 72k^2(1-u)^2 + 80k(1-u) + 35}{k^{10}[(1-u)(1-u+2/k)]^{9/2}},
$$
\n(3)

218 when  $\overline{R}$  is a geometric ratio and the non-219 dimensional parameters  $\beta$  and  $\gamma$  are proportional to the 220 magnitude of the electrostatic force and van der Waals 221 interactions, respectively, namely

$$
\beta = \frac{\pi \varepsilon_0 V^2 L^4}{H^2 EI}, \quad \gamma = \frac{C_6 \sigma^2 \pi^2 L^4}{2R^5 EI} \tag{4}
$$

223 where  $\varepsilon_0 = 8.854 \times 10^{-12} \text{ C}^2 \text{ N}^{-1} \text{ m}^{-2}$  is the per-224 mittivity of vacuum, V is the electric voltage applied to 225 the electrodes,  $C_6 = 15.2$  Ev  $\AA^6$  is a constant charac-226 terizing the interaction between carbon–carbon atoms,

227  $\sigma = 38$  nm<sup>-2</sup> is the graphene surface density, I  $\approx$  $\pi$ t

rotation at the clamped end  $(x = 0)$ , vanishing of the 244 bending moment and assigned shearing force at the 245 free end  $(x = 1)$ , namely 246

$$
u(0) = 0, \quad u'(0) = 0, \quad u''(1) = 0, u'''(1) = -\beta q(\delta), \tag{5}
$$

where  $\delta = u(1)$  is the tip displacement and 248

$$
q(\delta) = \frac{0.85\rho(1+k)^{2/3}}{\sqrt{(1-\delta)(1-\delta+2/k)}[\cosh^{-1}(1+k-k\delta)]^2},\tag{6}
$$

is the normalized shearing force due to the electro- 250 static attraction of the charge concentrated at the CNT 251 tip [13, 14, 27], being  $\rho = R/L$  the inverse of the CNT 252 slenderness. 253 , 254

By taking the derivative of Eq. (2) with respect to 
$$
u
$$
, 254 one obtains 255

$$
f'(u) = \beta f'_e(u) + \gamma F'_c(u),
$$
 (7)

$$
257\n\n258
$$

 $f'_e(u) =$ 1  $(1)$  $\overline{\phantom{0}}$  $u)($ 1  $\overline{\phantom{0}}$ u  $\overline{+}$ 2 =  $k)$ [ $\cosh$  $\overline{\phantom{0}}$ 1 ð 1  $\overline{+}$ k  $-ku$ 2 2 cosh  $\overline{\phantom{0}}$ 1 ð 1  $\boldsymbol{+}$ k  $-ku$ Þ  $\overline{\phantom{0}}$ 1  $\overline{\phantom{0}}$ u  $\overline{\phantom{0}}$ 1 = k  $\sqrt{(1-u)(1-u+2/k)}$  $\sqrt{ }$ 1 ;  $f'_c(u) = 5$ 8 k 5 ð 1  $\overline{\phantom{0}}$ u Þ 5  $+40$ k 4 ð 1  $\overline{\phantom{0}}$ u Þ 4  $+120$ k 3 ð 1 ÷ u Þ 3  $+200$ k 2 ð 1  $\overline{\phantom{0}}$ u Þ 2  $+175$ k ð 1  $\overline{\phantom{0}}$  $u) + 63$ k  $11[($ 1 ÷  $u)($ 1  $\overline{\phantom{0}}$ u  $\boldsymbol{+}$ 2 =  $(k)$ ]<sup>11</sup> / 2 : ð 8 Þ

228  $R<sup>3</sup>$  is the moment of inertia of the CNT cross-section, 229 where  $t$  is the CNT wall thickness, and  $E$  is the 230 Young's modulus of the graphene. A number of 231 studies based on experimental tests and atomistic 232 simulations found that the Young's modulus of the 233 graphene varies from 0.5 to 5.5 TPa and the single 234 wall thickness ranges between 0.7 and 3.4  $\AA$ , see the 235 summary of results given in [29]. The mean values 236 suggested in [29] are  $t = 1.34$  Å and  $E = 2.52$  TPa.

237 The van der Waals force per unit length  $(3)_2$  has been derived in [ 4] by taking the derivative with respect to the deflection of the van der Waals energy determined by double volume integral of the Lennard– Jones potential.

242 The boundary conditions for the cantilever EB 243 beam then require vanishing of displacement and

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$$
k = H
$$
  
ensional p  
initude of t



Note that the functions  $f(u)$  and  $f'(u)$  defined in (2) and 259 ( 7) are positive and monotonically increasing for 260  $0 \le u \le 1$  and  $k > 0$ , namely 261

$$
f(u) \ge f(0) \ge 0, \qquad f'(u) \ge f'(0) \ge 0,
$$
\n(9)

where 263

$$
f(0) = \frac{\beta}{\sqrt{(1+2/k)}[\cosh^{-1}(1+k)]^2} + \gamma \frac{8k^4 + 32k^3 + 72k^2 + 80k + 35}{k^{10}(1+2/k)^{9/2}},
$$
 (10)

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$$
f'(0) = \beta \frac{2\sqrt{k(2+k)} + (1+k)\cosh^{-1}(1+k)}{(2+k)\sqrt{(1+2/k)}[\cosh^{-1}(1+k)]^3} + 5\gamma \frac{8k^5 + 40k^4 + 120k^3 + 200k^2 + 175k + 63}{k^{11}(1+2/k)^{11/2}}.
$$
\n(11)

267 2.1 Nonlinear integral equation for  $u(x)$ 

tegral equation for  $u(x)$ <br>
les governing ODE (1) is integrated<br>
The normalized deflection of the two experimentary evaluations (5), in<br>
in  $\delta = u(1)$ , then must satisfy the follow<br>
prelliminary estimates about the<br>
derived 268 In this section, the governing ODE (1) is integrated 269 four times by using the boundary conditions ( 5), in 270 order to obtain preliminary estimates about the 271 solution  $u(x)$  and its derivatives up to the third order. 272 Moreover, a nonlinear integral equation for the 273 deflection  $u$  is obtained, which will be used later for 274 achieving accurate bounds for the pull-in parameters. 275 A first integration of the governing ODE (1) between x 276 and 1 by using the boundary condition  $(5)_4$  yields

$$
u'''(x) = -\int_{x}^{1} f(u(t))dt - \beta q(\delta).
$$
 (12)

278 Integration of Eq.  $(12)$  between x and 1, by using the 279 boundary condition  $(5)_3$  and integration by parts, then 280 yields

$$
u''(x) = \int_{x}^{1} (t-x)f(u(t))dt + (1-x)\beta q(\delta).
$$
 (13)

282 Integration of Eq.  $(13)$  between 0 and x, by using the 283 boundary condition  $(5)_2$  and integration by parts, then 284 yields

$$
u'(x) = \frac{1}{2} \left\{ x \int_{x}^{1} (2t - x)f(u(t))dt + \int_{0}^{x} t^2 f(u(t))dt + \beta q(\delta)(2 - x)x \right\}.
$$
\n(14)

286 Finally, integration of Eq.  $(14)$  between 0 and x by 287 using the boundary condition  $(5)_1$  and integration by 288 parts gives the following nonlinear integral equation 289  $u(x)$ 

$$
u(x) = \frac{1}{6} \left\{ x^2 \int_{x}^{1} (3t - x)f(u(t))dt + \int_{0}^{x} (3x - t)t^2 f(u(t))dt + \beta q(\delta)(3 - x)x^2 \right\}.
$$
\n(15)

The normalized deflection of the cantilever tip, 291  $\delta = u(1)$ , then must satisfy the following condition 292 derived from Eq. (15) for  $x = 1$  293

$$
\delta = \frac{1}{6} \int_{0}^{1} (3 - t)t^2 f(u(t)) dt + \frac{1}{3} \beta q(\delta).
$$
 (16)

Considering that  $f(u) \ge 0$  and  $q(\delta) \ge 0$ , from Eqs. ( 1), 295 (12)–(15) the following conditions then hold true for 296  $x \in [0, 1]:$  297

$$
u(x) \ge \frac{x^2}{6} (3 - x)\beta q(\delta) \ge 0,
$$
  
\n
$$
u'(x) \ge \left(x - \frac{x^2}{2}\right)\beta q(\delta) \ge 0,
$$
  
\n
$$
u''(x) \ge (1 - x)\beta q(\delta) \ge 0,
$$
  
\n
$$
u'''(x) \le -\beta q(\delta).
$$
\n(17)

Therefore, the function  $u(x)$  is positive, increasing and 299 convex for  $x \in (0, 1)$ . 300

#### 3 Two-side estimates for the deflection 301

In order to define upper and lower bounds to the pull-in 302 parameters, two-side estimates are first derived for the 303 deflection u(  $(x)$ . 304

3.1 Upper bounds to the deflection  $u(x)$ ) 305

Let  $u(x)$  denotes the solution to the BVP (1) and (5), 306 then it can be proved that  $u(x) \le u_U(x)$  for  $x \in [0, 1]$ , 307 where 308

$$
u_U(x) = \delta b_1(x) + \beta q(\delta) [b_2(x) + f'(0)b_3(x)], \quad (18)
$$

and 310



$$
b_1(x) = \frac{1}{3}x^2(x^2 - 4x + 6) \ge 0,
$$
  
\n
$$
b_2(x) = \frac{1}{18}x^2(1 - x)(2x - 3) \ge 0,
$$
\n(19)

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$$
b_3(x) = \frac{1}{5040}x^2(1-x)\left(x^4 - 6x^3 - 6x^2 + 38x - 33\right) \le 0.
$$
\n(20)

314 Indeed, let us define the function

$$
h(x) = \delta b_1(x) + \beta q(\delta) [b_2(x) + f'(0)b_3(x)] - u(x),
$$
\n(21)

316 then the derivatives of  $h(x)$  up to the fourth order 317 become

Therefore, the function  $h(x)$  satisfies all the require- 327 ments for the application of Lemma A reported in the 328 "Appendix", and thus  $h(x) \ge 0$  for  $x \in [0, 1]$ , so that, 329 by using the definition (21), the upper bound (18) for 330 the CNT deflection holds true.  $\Box$  331

The term  $\delta b_1(x)$  appearing in (18) coincides with 332 the quartic polynomial used for approximating 333 nanobeam deflection in [30]. Moreover, from condi- 334 tions (18), by using  $(9)_2$  and (20) it follows that  $335$ 

$$
u(x) \leq \delta b_1(x) + \beta q(\delta) b_2(x), \quad \text{for} \quad x \in [0, 1],
$$
\n(25)

Obviously, the upper bound (25) is less accurate than 337 (18), but it depends linearly on the parameter  $\beta$ . 338

UNCORRECTED PROOF h 0 ð Þ ¼ x 4 d x 33 x 2 þ x b 18 qð Þd f 0 ð 0 Þ 280 7 x 6 42 x 5 þ 176 x 3 213 x 2 þ 66 x þ 8 x 3 15 x 2 þ 6 x u 0 ð Þx ; h <sup>00</sup>ð Þ ¼ x 4 dð Þ 1 x 2 þ b3 qð Þ ð d 1 x Þ f 0 ð 0 Þ 280 7 x 4 28 x 3 28 x 2 þ 60 x 11 þ 4 x 1 u <sup>00</sup>ð Þx ; h <sup>000</sup>ð Þ ¼ x 8 dð Þ 1 x b3 qð Þd f 0 ð 0 Þ 280 35 x 4 140 x 3 þ 176 x 71 þ 8 x 5 u <sup>000</sup>ð Þx ; h IVð Þ ¼ x 8 d b3 qð Þd f 0 ð 0 Þ 70 35 x 3 105 x 2 þ 44 þ 8 u IVð Þx : ð22 Þ

 $(20)$ 

318

319 Moreover, by taking the derivative of  $h^{\text{IV}}(x)$ , using 320 Eq. ( 1), one has

$$
h^{V}(x) = \beta q(\delta) f'(0) \left( x - \frac{1}{2} x^{3} \right) - f'(u) u'(x) \le 0,
$$
\n(23)

322 where the last inequality follows from  $(9)_2$  and  $(17)_2$ ,

323 thus implying that the function  $h'''(x)$  is concave.

324 Then, the following conditions are met by function 325  $h(x)$  and its derivatives

$$
h(0) = 0, \quad h(1) = 0, \quad h'(0) = 0, \quad h''(1) = 0,
$$
  

$$
h'''(1) = 0, \quad h^{V}(x) \le 0.
$$
 (24)

Therefore, two slightly different procedures for deriv- 339 ing lower bound to the pull-in parameters will be 340 developed in Sect. 4.1 starting from the bounds (18 ) 341 and  $(25)$ , respectively.  $342$ 

3.2 Lower bounds to the deflection  $u(x)$ ) 343

Let  $u(x)$  denote the solution to the BVP (1) and (5), 344 then the lower bound  $u(x) \ge u_L(x)$  holds true for 345  $x \in [0, 1]$ , where 346

$$
u_L(x) = \delta a_1(x) + f(0)a_2(x) \tag{26}
$$

and 348

$$
a_1(x) = \frac{1}{2} (3x^2 - x^3) \ge 0,
$$
  
\n
$$
a_2(x) = \frac{1}{48} (3x^2 - 5x^3 + 2x^4) \ge 0.
$$
\n(27)

Let us indeed define the following function 350

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$$
g(x) = u(x) - \frac{\delta}{2} (3x^2 - x^3)
$$
  
 
$$
-\frac{f(0)}{48} (3x^2 - 5x^3 + 2x^4),
$$
 (28)

352 then the derivatives of  $g(x)$  write

$$
g'(x) = u'(x) - \frac{3}{2}\delta(2x - x^2) - \frac{f(0)}{48}(6x - 15x^2 + 8x^3),
$$
  
\ncondition  
\n $g''(x) = u''(x) + 3\delta + (5 - 8x),$   
\n $g''(x) = u''(x) + 3\delta + (5 - 8x),$   
\n $g''(x) = u''(x) - f(0) \ge 0,$   
\nwhere the latter inequality follows from Eqs. (1) and  
\n $g' = 0$ ,  
\nwhere the latter inequality follows from Eqs. (1) and  
\n $g' = 0$ ,  
\n $g(0) = 0$ ,  
\n $g(1) = 0$ ,  
\n $g'(0) = 0$ ,  
\n $g''(1) = 0$ .  
\nTherefore, the function  $g(x)$  satisfies the follow-  
\n $g(0) = 0$ ,  
\n $g(1) = 0$ ,  
\n $g'(0) = 0$ ,  
\n $g''(1) = 0$ .  
\nTherefore, the function  $g(x)$  satisfies all the require-  
\nments for the application of Lemma B proved in  
\n $g(0, \beta) = \frac{1}{6} \int_{0}^{1} r^2(3 - t) \{b_1(t) + \beta q'(\delta)$   
\n $g(0) = 0$ ,  
\n $g(1) = 0$ ,  
\n $g'(0) = 0$ ,  
\n $g''(1) = 0$ .  
\n $g'''(1) = 0$ .  
\n $g'''(1) = 0$ 

354 where the latter inequality follows from Eqs. ( 1) and 355  $(9)_1$ . Therefore, the function  $g(x)$  satisfies the follow-356 ing boundary conditions

$$
g(0) = 0
$$
,  $g(1) = 0$ ,  $g'(0) = 0$ ,  $g''(1) = 0$ . (30)

358 Therefore, the function  $g(x)$  satisfies all the require-359 ments for the application of Lemma B proved in 360 "Appendix". It follows that  $g(x) \ge 0$  for  $x \in [0, 1]$ , so 361 that, by using the definition (28), the lower bound (26 ) 362 for the CNT deflection holds true.  $\Box$ 

#### 363 4 Bounds to the pull-in parameters

364 By introducing the estimates (18), (25) and (26) on the 365 deflection  $u(x)$  in relation (16), the following lower 366 and upper bounds to the pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$ 367 can be derived analytically.

- 368 4.1 Accurate lower bounds to the pull-in 369 parameters
- $370$  By using  $(9)_2$  and the upper bound to the CNT
- 371 deflection (18) one has  $f(u) \le f(u_U)$ , then from (16) it 372 follows

$$
\delta \le F(\delta, \beta) + \frac{\beta}{3} q(\delta),\tag{31}
$$

374 where the function

$$
F(\delta, \beta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) f(u_{U}(t)) dt
$$
 (32)

can be calculated numerically. 376

Condition (31) defines a lower bound to the relation 377 between the electrostatic loading parameter  $\beta$  and the 378 normalized pull-in deflection  $\delta$ . The maximum value 379 of the parameter  $\beta$  and the corresponding tip deflection 380  $\delta$  obtained from relation (31) by using the stationary 381 condition 382

$$
\frac{\partial \beta}{\partial \delta} = 0,\tag{33}
$$

then define the lower bounds of the pull-in parameters 384  $\beta_L$  and  $\delta_L$ , such that  $\beta_{PI} \geq \beta_L$  and  $\delta_{PI} \geq \delta_L$ , which are 385 given by the following two conditions 386

$$
F(\delta_L, \beta_L) + \frac{\beta_L}{3} q(\delta_L) = \delta_L, \n\Phi(\delta_L, \beta_L) + \frac{\beta_L}{3} q'(\delta_L) = 1,
$$
\n(34)

where the function 388

$$
\Phi(\delta, \beta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) \{b_{1}(t) + \beta q'(\delta) [b_{2}(t) + f'(0)b_{3}(t)]\} f'(u_{U}(t)) dt
$$
\n(35)

can be calculated numerically and is given by the 390 derivative with respect to  $\delta$  of the function  $F(\delta, \beta)$ ) 391 defined in (32), performed by considering the maxi- 392 mization condition (33) and the definition (18) of  $u_U$ . 393

#### 4.1.1 Lower bounds to the pull-in parameters 394

By using the estimate (25) and the monotony condi- 395 tions  $f'_e(u) \ge 0$  and  $f'_c(u) \ge 0$ , from (16) it follows 396

$$
\delta \leq \beta f_e(\delta) + \gamma F_c(\delta) + \frac{\beta}{3} q(\delta),\tag{36}
$$

where the functions 398

$$
F_e(\delta) = \frac{1}{6} \int_{0}^{1} t^2 (3 - t) f_e(\delta b_1(t) - \beta q(\delta) b_2(t)) dt,
$$
\n(37)

$$
F_c(\delta) = \frac{1}{6} \int_{0}^{1} t^2 (3 - t) f_c(\delta b_1(t) - \beta q(\delta) b_2(t)) dt,
$$
\n(38)

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400

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402 can be calculated numerically.

403 Condition (36) defines a lower bound to the relation 404 between the electrostatic loading parameter  $\beta$  and the  $405$  normalized pull-in deflection  $\delta$ . In this case, inequality 406 (36) can be easily solved for the parameter  $\beta$ . The 407 maximum value of the parameter  $\beta$  and the corre-408 sponding tip deflection  $\delta$  obtained from relation (36) 409 by using the stationary condition (33) then provides 410 the lower bounds of the pull-in parameters  $\beta_L$  and  $\delta_L$ . 411 Namely, the latter values are given by the conditions

$$
\beta_L F_e(\delta_L) + \gamma F_c(\delta_L) + \frac{\beta_L}{3} q(\delta_L) = \delta_L, \n\beta_L F'_e(\delta_L) + \gamma F'_c(\delta_L) + \frac{\beta_L}{3} q'(\delta_L) = 1,
$$
\n(39)

413 where the apex denotes the derivative with respect to 414 the function argument within the brackets, namely

$$
F'_{e}(\delta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) [b_{1}(t) - \beta q'(\delta) b_{2}(t)] f'_{e}(\delta b_{1}(t) - \beta q(\delta) b_{2}(t)) dt,
$$

416

$$
F'_{c}(\delta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) [b_{1}(t) - \beta q'(\delta) b_{2}(t)] f'_{c}(\delta b_{1}(t) - \beta q(\delta) b_{2}(t)) dt.
$$
\n(41)

418 The latter functions can be calculated numerically and 419 are given by the derivative with respect to  $\delta$  of the 420 functions defined in (37) and (38), performed by 421 considering the maximization condition (33).

#### 422 4.2 Upper bounds to the pull-in parameters

423 By using  $(9)_2$  and the lower bound to the CNT 424 deflection (26) it follows that  $f(u) \ge f(u_L)$ , then from 425 (16) one has

$$
\delta \ge G(\delta, \beta) + \frac{\beta}{3} q(\delta),\tag{42}
$$

427 where the function

$$
G(\delta, \beta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) f(u_{L}(x)) dt
$$
 (43)

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can be calculated numerically. 429

Inequality  $(42)$  implicitly defines an upper bound to  $430$ the relation between the parameters  $\beta$  and  $\delta$ . The 431 maximum value of the parameters  $\beta$  and the corre- 432 sponding tip deflection  $\delta$  obtained from this relation by 433 using the stationary condition (33) then provides the 434 upper bounds of the pull-in parameters  $\beta_U$  and  $\delta_U$ , 435 such that  $\beta_{PI} \leq \beta_U$  and  $\delta_{PI} \leq \delta_U$ . Therefore, the upper 436 bounds follow from the two conditions 437

$$
G(\delta_U, \beta_U) + \frac{\beta_U}{3} q(\delta_U) = \delta_U,
$$
  
\n
$$
\Gamma(\delta_U, \beta_U) + \frac{\beta_U}{3} q'(\delta_U) = 1,
$$
\n(44)

where the function 439

 $(40)$ 

$$
\Gamma(\delta, \beta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) a_{1}(t) f'(u_{L}(x)) dt,
$$
\n(45)

can be calculated numerically and is given by the 441 derivative with respect to  $\delta$  of the function  $G(\delta, \beta)$ ) 442 defined in (43), performed by considering the maxi- 443 mization condition (33) and the definition (26) of  $u<sub>L</sub>$ . 444

4.3 Ke et al. estimates to the pull-in voltage 445

The following approximated relation for the pull-in 446 voltage of a CNT whose radius  $R$  is much smaller than  $447$ the gap spacing  $H$  between the CNT and ground plane,  $448$ namely for  $k \gg 1$  has been proposed in [14] 449

$$
V_{\rm PI} = 0.85 \sqrt{\frac{1 + K^{FK}}{1 + K^{TIP}} \frac{H}{L^2} \ln\left(2\frac{H}{R}\right) \sqrt{\frac{EI}{\epsilon_0}},\tag{46}
$$

where the parameters 451

section to obtain from relation (35) upper bounds on the pull-in parameters 
$$
\rho_U
$$
 and  $\delta_{UV} \leq \delta_{UV}$ . Therefore, the upper sum of relations

\nδ<sub>L</sub> +  $\frac{\beta_L}{3}q(\delta_L) = \delta_L$ ,  $r(\delta_U, \beta_U) + \frac{\beta_U}{3}q(\delta_U) = \delta_U$ ,  $r(\delta_U, \beta_U) + \frac{\beta_U}{3}q(\delta_U) = \delta_U$ ,  $r(\delta_U, \beta_U) + \frac{\beta_U}{3}q(\delta_U) = 1$ , where the function

\n3*− 1 [b<sub>1</sub>(*t*) – β<sub>1</sub>(*t*)*b<sub>2</sub>(*t*)*b<sub>2</sub>(*t*)*b<sub>2</sub>(*t*)*b<sub>2</sub>(*t*)*b<sub>2</sub>(*t*)*b<sub>2</sub>(*t*)*b<sub>2</sub>(*t*)*b<sub>2</sub>(*t*)*b<sub>2</sub>(*t*)*b<sub>2</sub>(*t*)*t*)***********

\n4*.* **4 5 6 6 6 6 6 6 6 6 6 6**

take into account for the effects of finite kinematics 453 and concentrated-tip charge, respectively.Considering 454 the definition  $(4)_1$  of the normalized pull-in voltage, 455 from  $(46)$  and  $(47)$  it follows 456

$k=1$	$\rho = 0.01$				$\rho = 0.05$				$\rho = 0.1$			
$\gamma$	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$	$\delta_L$	$\beta_L$	$\delta_{U}$	$\beta_U$
$\Omega$	0.5119	5.8346	0.5193	5.9082	0.4884	4.8695	0.4923	4.9062	0.4700	4.0432	0.4722	4.0619
0.1	0.4017	4.2413	0.4088	4.3134	0.3942	3.6010	0.3996	3.6477	0.3874	3.0298	0.3917	3.0601
0.2	0.3477	3.0363	0.3550	3.1098	0.3437	2.5965	0.3500	2.6497	0.3401	2.1983	0.3455	2.2368
0.3	0.3091	1.9975	0.3167	2.0724	0.3070	1.7162	0.3139	1.7744	0.3050	1.4591	0.3113	1.5043
0.4	0.2785	1.0613	0.2862	1.1374	0.2775	0.9150	0.2848	0.9774	0.2766	0.7805	0.2836	0.8313
0.5	0.2527	0.1975	0.2606	0.2744	0.2526	0.1708	0.2603	0.2365	0.2524	0.1460	0.2600	0.2016

**Table 1** Lower and upper bounds of the pull-in parameters for a CNT switch with  $k = 1.0$ , for various values of the van der Waals parameter  $\gamma$  and geometric ratio  $\rho$ 

**Table 2** Lower and upper bounds of the pull-in parameters for a CNT switch with  $k = 10$ , for various values of the van der Waals parameter  $\gamma$  and geometric ratio  $\rho$ 

0.2	0.3477	3.0363	0.3550	3.1098	0.3437	2.5965	0.3500	2.6497	0.3401	2.1983	0.3455	2.2368
0.3	0.3091	1.9975	0.3167	2.0724	0.3070	1.7162	0.3139	1.7744	0.3050	1.4591	0.3113	1.5043
0.4	0.2785	1.0613	0.2862	1.1374	0.2775	0.9150	0.2848	0.9774	0.2766	0.7805	0.2836	0.8313
0.5	0.2527	0.1975	0.2606	0.2744	0.2526	0.1708	0.2603	0.2365	0.2524	0.1460	0.2600	0.2016
				Table 2 Lower and upper bounds of the pull-in parameters for a CNT switch with $k = 10$ , for various values of the van der Waals								
parameter $\gamma$ and geometric ratio $\rho$ $k = 10$ $\rho = 0.01$						$\rho = 0.05$			$\rho = 0.1$			
γ	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$
$\overline{0}$	0.4978	18.515	0.5029	18.687	0.4565	11.939	0.4578	11.975	0.4363	8.2986	0.4368	8.3090
$2 \times 10^4$	0.4176	14.924	0.4235	15.114	0.3985	9.8578	0.4015	9.9198	0.3876	6.9270	0.3895	6.9538
$4 \times 10^{4}$	0.3725	12.060	0.3789	12.263	0.3607	8.0684	0.3648	8.1521	0.3537	5.7083	0.3567	5.7512
$6 \times 10^{4}$	0.3394	9.5547	0.3461	9.7693	0.3316	6.4495	0.3365	6.5520	0.3269	4.5860	0.3309	4.6443
$8 \times 10^4$	0.3127	7.2818	0.3197	7.5054	0.3075	4.9490	0.3132	5.0683	0.3043	3.5334	0.3092	3.6063
$10 \times 10^{4}$	0.2901	5.1768	0.2973	5.4081	0.2868	3.5381	0.2930	3.6725	0.2847	2.5347	0.2904	2.6215
Fig. 2 Relations between $(a)$ <sub>6</sub> electrostatic loading $k = 1.0$ parameter $\beta$ and tip $k = 0.8$ 5 deflection δ obtained from $k = 0.6$ the shooting method, for $k = 0.4$ 4 various geometric ratios $k = 0.2$ k and two different values of $\infty$ 3 $\gamma$ . Lower and upper estimates of the pull-in $\overline{2}$ parameters are denoted by small circles and small points, respectively $\mathbf{1}$ $\boldsymbol{0}$ $\overline{0}$ 0.1					0.2 0.3 $\delta$	0.4	$\rho = 0.02$ $\gamma = 10^{-5}$ 0.5 0.6	( <b>b</b> ) 30 25 20 മ 15 10 5 $\mathbf{0}$ $\mathbf 0$	$k = 50$ $k = 20$ $k = 10$ $k = 5$ 0.1	0.2 0.3 δ	0.4	$\rho = 0.02$ $\gamma = 0.2$ 0.5 0.6
							5 Results					
	$\pi \varepsilon_0 V_{\rm Pl}^2 L^4$		$6.952 + K^{FK}$	$\frac{1}{2}$ $\frac{1}{2}$ $\frac{1}{2}$								







$$
\beta_{\text{Ke}} = \frac{\pi \varepsilon_0 V_{PI}^2 L^4}{EI H^2} = \pi 0.85^2 \frac{1 + K^{FK}}{1 + K^{TIP}} \ln^2 \left( 2 \frac{H}{R} \right)
$$
  
=  $\pi 0.85^2 \frac{(1 + 8 k^2 \rho^2 / 9) \ln^2(2k)}{1 + 2.55 \rho (k + 1)^{2/3}}$ . (48)

#### 5 Results 459

Lower and upper estimates for the normalized pull-in 460 voltage  $\beta_L$  and  $\beta_U$  and the corresponding estimates of 461 the normalized pull-in deflection  $\delta_U$  and  $\delta_L$  have been 462 reported in Tables 1 and 2. In these tables, two 463 different values of the geometric ratio  $k$  are considered  $464$ 







Fig. 3 Relations between electrostatic loading parameter  $\beta$  and tip deflection  $\delta$  obtained from the shooting method, for the geometric ratios  $k = 1$  (a) and  $k = 10$  (b) and various values of



Fig. 4 Relations between electrostatic loading parameter  $\beta$  and tip deflection  $\delta$  obtained from the shooting method, for  $k = 1$ and  $\gamma = 0.1$  (a) and  $k = 10$  and  $\gamma = 0.2$  (b), for various

465 and results are listed for three specific values of the 466 ratio  $\rho = R/L$ , which denotes the inverse of the CNT 467 slenderness, and for some specific set of the normal-468 ized van der Waals parameter  $\gamma$  defined in Eq. (4)<sub>2</sub>.

 In order to validate the analytical estimates pro- vided here, the solution to the nonlinear BVP defined by Eqs. ( 1) and ( 5) has been calculated by using the numerical integration scheme available in Mathemat- $ica^{\circledR}$ , which is based on the shooting method. Figures 2 , 3, and 4 show the relationships between 475 the electrostatic loading parameter  $\beta$  and tip deflection 476 of the CNT,  $\delta = u(1)$ , obtained by using the function 477 DSolve of *Mathematica*<sup>®</sup>, varying the geometric and material parameters of the CNT switch. In these

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the van der Waals parameter  $\gamma$ . Lower and upper estimates of the pull-in parameters are denoted by small circles and small points, respectively



geometric ratios q. Lower and upper estimates of the pull-in parameters are denoted by small circles and small points, respectively

figures, the lower and upper analytical estimates of the 479 pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$  calculated by using the 480 accurate method described in Sects. 4.1 and 4.2 are 481 marked with small circles and points, respectively. In 482 particular, the curves in Fig. 2 display the variation of 483 normalized CNT tip deflection  $\delta$  with the electrostatic 484 loading parameter β obtained from the shooting 485 method, for various values of the geometric ratio  $k$ . 486 A slender CNT ( $\rho = 0.02$ ) subject to weak inter- 487 molecular surface forces ( $\gamma = 10^{-5} \div 0.2$ ) is consid- 488 ered therein. These results confirm that the lower and 489 upper analytical bounds for  $\beta$  and  $\delta$  are very close each 490 other (for all the values of the parameter  $k$  considered 491 here), thus ensuring extremely accurate estimates of 492 Author Proofuthor

493 the exact pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$ , which 494 correspond to the maximum of the curves  $\beta$  versus  $\delta$ 495 obtained by the numerical integration procedure. As 496 expected, the pull-in voltage  $\beta_{PI}$  is found to increase  $497$  with the gap spacing  $H$  between the electrodes, which 498 is proportional to the parameter  $k$ . The pull-in tip 499 displacement  $\delta_{PI}$  displays a non monotonic behavior 500 as  $k$  is increased. Indeed, it grows for small values of 501 k and then it decreases as k becomes larger. The 502 contribution of the charge concentrated at the CNT 503 free end has been neglected in most investigations, 504 which thus overestimate the pull-in voltage. Actually, 505 the pull-in voltage is significantly reduced when the 506 contribution of the concentrated load acting at the free 507 end is taken into account.

 Figure 3 is similar to Fig. 2 except that it focuses on the effects of the van der Waals attractions on the pull-510 in parameters. The same geometric ratio  $\rho = 0.02$  considered in Fig. 2 has been assumed here. As the beam deflection increases and the normalized gap spacing 1- u decreases, the van der Waals interaction becomes stronger than the electrostatic force. Their magnitude indeed varies with the gap spacing accord- ing to the different laws introduced in (3). If the 517 magnitude  $\gamma$  of the van der Waals interaction increases, then it becomes effective at larger gap spacing and, thus, both the pull-in voltage and the pull- in tip deflection are found to decrease, as it can be observed in Fig. 3a, b. These plots also confirm that 522 the analytical lower and upper bounds for  $\beta$  and  $\delta$  are very close each other and, thus, also to the exact pull-524 in parameters  $\beta_{PI}$  and  $\delta_{PI}$ , which should lay in 525 between.

The effects of the geometric ratio  $\rho$  on the pull-in 526 parameters can be observed in Fig. 4 for two sets of 527 values of  $\gamma$  and k. As  $\rho$  decreases, namely for slender 528 CNT, the normalized pull-in voltage  $\beta_{PI}$  increases 529 together with the corresponding normalized tip deflec- 530 tion  $\delta_{PI}$ . Note the effects of the CNT slenderness ratio 531 q are more evident for large gap spacing, namely for 532  $k \gg 1$  (Fig. 4b). 533

Indeed, it grows for small values of  $k \gg 1$  (Fig. 4b).<br>
Indeed, it grows for small values of  $k \gg 1$  (Fig. 4b).<br>
Beckering and becomes larger The The twaristons of the variate Waals<br>
the charge concentrated ta the CNT wi The variations of the van der Waals parameters  $\gamma$ 534 with the tip displacement  $\delta$  for a freestanding CNT 535 cantilever ( $\beta = 0$ ) obtained by numerical integration 536 are plotted in Fig. 5 for various values of the 537 geometric ratio k. If the parameter  $\gamma$  exceeds its 538 critical value  $\gamma_{PI}$ , which is given by the maximum of 539 the  $\gamma$ - $\delta$  curve obtained by numerical integration, then 540 pull-in instability occurs even if no electric voltage is 541 applied to the electrodes. It can be observed that the 542 estimated values of  $\gamma_{PI}$  and the corresponding pull-in 543 deflection  $\delta_{PI}$  agree very well with the results of the 544 numerical procedure. These plots also show that the 545 critical values of van der Waals parameter is increased 546 by increasing the geometric ratio  $k$ . No significant  $547$ influence of  $k$  has been observed on the normalized  $548$ pull-in tip deflection  $\delta_{PI}$ , which turns out to be about 549 constant and equal to  $0.25$ , independently of  $k$ . Lower  $550$ and upper estimates of critical van der Waals param- 551 eter  $\gamma_{PI}$  and tip deflection  $\delta_{PI}$  for a freestanding CNT 552 can be found in Table 3 for some values of the 553 geometric ratio k. There, it can be noted that a stronger 554 van der Waals force is required to induce the pull-in 555 instability as the normalized gap spacing  $k$  increases,  $556$ whereas the normalized pull-in tip deflection  $\delta$  is 557 almost independent of k. Note that the geometric ratio 558  $\rho$  has no effect on the pull-in value  $\gamma_{PI}$  of the van der 559

Fig. 5 Relations between **(a)** van der Waals parameter γ and tip deflection  $\delta$  obtained from the shooting method, for a freestanding nanotube  $(\beta = 0)$  and for small (a) and large ( b) values of the geometric ratio k. Lower and upper estimates of the pullin parameters are denoted by small circles and small points, respectively







Table 3 Lower and upper bounds for the parameters  $\gamma$ and d causing the pull-in instability in the absence of electrostatic actuation  $(\beta = 0)$  and approximated value  $\gamma_{PI}^*$  provided by Eq. (49), for various values of the geometric ratio k



Fig. 6 Variation of the van der Waals parameter  $\gamma_{PI}^*$ with the geometric ratio k. The upper and lover values of  $\gamma$  causing the pullin instability for a freestanding CNT cantilever are marked by full and empty circles, respectively



voltage  $\beta$  with the van der Waals parameter  $\gamma$ , for small ( a) and large ( b) values of

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variations of the pull-in the geometric ratios k

				560 Waals parameter. Indeed, according to Eq. $(6)$ $\rho$	
				561 affects the concentrated tip load only, which is	
562 vanishing for $\beta = 0$ .					

On the basis of the performed investigations a 563 simple closed-form relation is proposed here for the 564

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565 pull-in value of the van der Waals parameter for a 566 freestanding CNT cantilever, namely

$$
\gamma_{PI}^* = \frac{1}{2} k^{11/2}.
$$
\n(49)

568 The variations of  $\gamma_{PI}^*$  with k are plotted in Fig. 6a, b 569 together with the upper and lower bounds  $\gamma_U$  and  $\gamma_L$ 570 provided by the present analysis. Values of  $\gamma_{PI}^*$  for 571 some specific value of  $k$  have been reported in Table 3 572 also. In Fig. 6a, it can be noted that relation (49) fits 573 very well the lower bounds  $\gamma_U$  for small values of k, 574 namely for  $k < 2.8$ , and thus it can be conveniently 575 used for the safe design of CNT switches with a small 576 gap spacing. Equation (49) provides accurate predic-577 tions also for  $k > 2.8$ , as it can be observed in Fig. 6b, 578 but in this case  $\gamma_{PI}^*$  may result a bit larger than  $\gamma_U$ , as it 579 can be noted in Table 3 for  $k = 3 \div 5$ . Relation (49) 580 actually defines a minimum gap spacing  $H_{min}$  or,

equivalently, a maximum CNT length  $L_{max}$  for 581 preventing the pull-in collapse of a CNT in the 582 absence of electrostatic loading, namely 583

$$
H_{min} = \left(C_6 \sigma^2 \frac{\pi^2 L^4}{EI}\right)^{2/11} R^{1/11},
$$
  

$$
L_{max} = \left(\frac{EI}{C_6 \sigma^2 \pi^2}\right)^{1/4} \left(\frac{H^{11}}{R}\right)^{1/8}.
$$
 (50)

The variations of  $\beta_U$  and  $\beta_L$  with  $\gamma$  are plotted in Fig. 585 for various value of the geometric ratio k. These 586 estimates are very close each other and, thus, 587 extremely accurate, for every value of the van der 588 Waals parameter. Both the pull-in voltage  $\beta$  and the 589 limit value of the coefficients  $\gamma$  increase as the 590 parameter  $k$  is increased. In general, for assigned 591 geometry, namely for given values of  $\rho$  and  $k$ , the pull- 592 in voltage decreases as the strength of the van der 593 Waals attractions increases. The pull-in voltage 594



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Fig. 8 Variations of lower and upper bounds  $\beta_L$  and  $\beta_U$ of the pull-in voltage with the geometric ratio k, for  $\gamma = 0$  and for various geometric ratios q

 $\delta_{\scriptscriptstyle U}$ δ*L*

k, for  $\gamma = 0$  and for two different geometric ratios p





 vanishes when the van der Waals parameter attains its 596 critical values  $\gamma_{\text{PI}}$ . Negative values of  $\beta$  then imply that a repulsive electrostatic force is required to prevent pull-in instability induced by the van der Waals attraction when it overcomes the elastic restoring force. In this case, the CNT collapses onto and adheres to the ground plane in the absence of electrostatic actuation, due only to the van der Waals attraction that is responsible of the occurring of stiction [31]. This phenomenon is exploited in non-volatile memory cells, where the switch is hold in the closed state with no need of continued power input. The occurrence of stiction in applications such as nanoactuators, nanoresonators and nano-tweezers may instead limit the range of operability of the device and lead to undesirable consequences.

611 The variations of lower and upper bounds of the 612 pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$  with the geometric ratio

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k are plotted in Figs. 8 and 9, respectively, for 613 vanishing contribution of the van der Waals force 614  $(\gamma = 0)$ . The lower and upper analytical bounds turn 615 out to be very close each other for every value of the 616 geometric ratio  $k$ , thus ensuring accurate estimates of  $617$ the pull-in parameters. Moreover, the pull-in voltage is 618 found to increase with the gap spacing parameter  $k$ , as  $619$ expected, and it seems to approach an almost constant 620 limit values for large  $k$ . Note that the pull-in deflection  $621$  $\delta_{PI}$  display a limited variation with k so that the range 622 of variation of the plots in Fig. 9 has been restricted 623 between 0.4 and 0.6 to make the gap more visible. Due 624 to the adopted graphical representation, it may seem 625 that the predicted upper and lower pull-in deflections 626  $\delta_L$  and  $\delta_U$  in Fig. 9 are more separated than the upper 627 and lower pull-in voltages plotted in Fig. 8, but 628 actually the former are as close as the latter. 629

*k*

ρ

 $k = 0.6$ 



Fig. 11 Variation of approximated normalized pull-in voltage  $\beta_{\rm Ke}$  with  $k$  for four values of slenderness ratio ρ: considering both effects of concentrated charge and finite kinematics (solid line), considering only the effect of concentrated charge (dashed line), neglecting both effects (dash-dotted line). The analytical predictions of the lower and upper bounds are plotted by solid and dashed black lines, respectively



630 The variations of lower and upper bounds of the 631 pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$  with the geometric ratio 632  $\rho$  are plotted in Fig. 10a, b, respectively, neglecting 633 the contribution of the van der Waals attractions 634  $(\gamma = 0)$ . It can be observed that increasing the 635 geometric ratio  $\rho$  results in decreasing the pull-in 636 voltage (Fig. 10a) and the normalized pull-in dis-637 placement (Fig. 10b). The rapid variation observed for 638  $k = 10$ , namely for large gap spacing, proves that the 639 pull-in parameters are very sensitive to the geometric 640 ratio q, especially when it is small, namely for very 641 slender CNTs. Note the reduced range of variation 642 considered for  $\delta_L$  and  $\delta_U$  in Fig. 10b.

 According to Eq. (48), the variations of the approx-644 imated pull-in voltage  $\beta_{\text{Ke}}$  proposed by Ke et al. [14] 645 with  $k$  are plotted in Fig. 11 for four values of  $\rho$ . In particular, the blue solid lines take into consideration both the effects of concentrated charge and finite kinematics, the red dashed lines take into considera- tion the effect of concentrated charge only, and the green dash-dotted lines neglect both effects. The analytical predictions of the lower and upper bounds 651 proposed here are plotted in the same figures by solid 652 and dashed black lines, respectively. From Fig. 11 it 653 can be observed that the effect of finite kinematics, 654 namely the term  $K^{FK}$ , is negligible for  $k < 20$  if 655  $\rho = 0.005$ , for  $k < 15$  if  $\rho = 0.01$ , for  $k < 10$  if 656  $\rho = 0.02$ , and for  $k < 5$  if  $\rho = 0.05$ , whereas the effect 657 of concentrated charge  $K^{TIP}$  can never be neglected. 658 Moreover, if the effects of finite kinematics are 659 neglected, relation (48) roughly approximates the 660 estimates of the pull-in voltage obtained by the present 661 approach. However, Eq.  $(48)$  provides estimates of the 662 pull-in voltage smaller than the lower bound  $\beta_L$  for 663 small values of  $k$  and larger than the upper bound  $\beta$ 664 for large values of k . 665 and by  $\frac{6}{40}$  of  $\frac{1}{20}$  of  $\frac{1}{20}$  and  $\frac{1}{20}$  and  $\frac{1}{20}$  and  $\frac{1}{20}$  and dashed black lines, respectively. From Fig. 11 it 653 and dashed black lines, respectively. From Fig. 11 it 653 and dashed bla

#### 6 Conclusions 666

Analytical lower and upper bounds for the pull-in 667





 CNT cantilever switch are proposed and then vali- dated by comparison with the results obtained from a numerical integration procedure of the governing nonlinear BVP. The combined effects of tip charge concentration and van der Waals attractions are found to reduce the pull-in voltage considerably. The upper and lower bounds are very close to the exact values, for every set of material and loading parameter considered here, thus proving the efficiency of the proposed approach. Moreover, they are found to improve the accuracy with respect to approximated relations proposed in the literature for the fast estimate of the pull-in voltage of CNT switches.

 In conclusion, the present study can be regarded as a useful tools for the safe design of NEMS devices exploiting the smart properties of CNTs. It allows indeed for preventing unpredicted structural damage during operation, thus assuring robust and consistent performance over many actuation cycles.

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691 Compliance with ethical standards

692 **Conflict of interest** The authors declare that they have no 693 conflict of interest. conflict of interest.

#### 694 Appendix

 The proofs of the two lemmas used in Sect. 3 for obtaining the upper and lower bounds to the CNT deflection are given in the following. These proofs were also given in [16 , 17] and are reported here for the sake of convenience.

700 **Lemma A** Let the function  $h(x)$  be continuous up to 701 the third derivative for  $x \in [0, 1]$  and satisfy the 702 following conditions

$$
h(0) = 0, \quad h(1) = 0, \quad h'(0) = 0, \quad h''(1) = 0, \quad h'''(1) = 0,
$$
\n
$$
(51)
$$

704 and

 $h^{V}(x) \leq 0$ , for  $x \in [0, 1]$  (52)  $(52)$ 

706 then

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 $h(x) \ge 0$ , for  $x \in [0, 1]$  (53  $(53)$ 

*Proof* By using the mean value theorem, from con-  $\frac{702}{60}$ tinuity and conditions  $(51)_{1,2}$  it follows that there 709 exists  $x_1 \in [0, 1]$  such that  $h'(x_1) = 0$ . Then, by using 710 conditions  $(51)_{3,4}$  there exist  $x_2 \in [0, x_1]$  and  $x_3 \in [x_2]$ , 711 1] such that  $h''(x_2) = 0$  and  $h'''(x_3) = 0$ . Since the 712 function  $h'''(x)$  is concave for  $x \in [0, 1]$  according to 713 (52), it follows that  $h''(x) \le 0$  for  $x \in [x_2, 1]$  and 714  $h''(x) \ge 0$  for  $x \in [0, x_2]$ . Therefore,  $h'(x) \ge 0$  for 715  $x \in [0, x_1]$  and  $h'(x) \le 0$  for  $x \in [x_1, 1]$ . Since 716  $h(0) = h(1) = 0$  according to Eq.  $(51)_{1,2}$ , then it nec- 717 essarily follows that  $h(x) \ge 0$  for  $x \in [0, 1]$ , so that 718 condition (53) holds true.  $\Box$  719

**Lemma B** Let the function  $g(x)$  be continuous up to 720 the third derivative for  $x \in [0, 1]$  and satisfy the fol- 721 lowing conditions 722

$$
g(0) = 0
$$
,  $g(1) = 0$ ,  $g'(0) = 0$ ,  $g''(1) = 0$ . (54)

$$
and \t\t\t\t\t724
$$

 $g^{\text{IV}}(x) \geq 0$  $, \text{ for } x \in [0, 1]$  (55

then 726

 $g(x) \geq 0$  $, \text{ for } x \in [0, 1]$  (56  $(56)$ 

f material and loading parameter<br>
function  $h'''(x)$  is concave for  $x \in [0, 1]$ , that proving the efficiency of the  $(S_0)$ , it follows that  $h''(x) \ge 0$  for  $x \in [1, 1]$ <br>
thus, moreover, they are found to  $h''(x) \ge 0$  for  $x \in$ *Proof* By using the mean value theorem, from con-  $\frac{727}{728}$ ditions  $(54)_{1,2}$  it follows that there exists  $x_1 \in [0, 1]$  729 such that  $g'(x_1) = 0$ . Moreover, by using conditions 730  $(54)_{3,4}$  there exists  $x_2 \in [0, x_1]$  such that  $g''(x_2) = 0$ . 731 Condition (55) then implies that  $g''(x)$  is convex. It 732 follows that  $g''(x) \le 0$  for  $x \in [x_2, 1]$  and  $g''(x) \ge 0$  733 for  $x \in [0, x_2]$ , and thus  $g'(x) \ge 0$  for  $x \in [0, x_1]$  and 734  $g'(x) \le 0$  for  $x \in [x_1, 1]$ . Since  $g(0) = g(1) = 0$  735 according to conditions  $(54)_{1,2}$ , then it necessarily 736 follows that inequality (56) holds true.  $\Box$  737 738

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\begin{array}{c}\n\ddots \\
\hline\n\end{array}
$$

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